- Package Options include Plastic Small Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

description

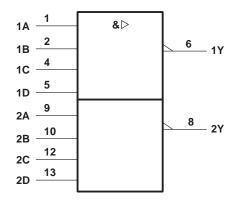
These devices contain two independent 4-input NAND buffer gates. They perform the Boolean functions $Y = \overline{A} \cdot B \cdot C \cdot D$ or $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$ in positive logic.

The SN54ALS40A is characterized for operation over the full military temperature range of -55° C to 125°C. The SN74ALS40A is characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each gate)

	INP	OUTPUT		
Α	В	С	D	Υ
Н	Н	Н	Н	L
L	Χ	Χ	Χ	Н
Х	L	X	Χ	Н
Х	X	L	Χ	Н
Х	Χ	Χ	L	Н

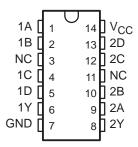
logic symbol†



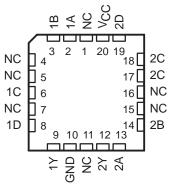
[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, and N packages.

SN54ALS40A . . . J PACKAGE SN74ALS40A . . . D OR N PACKAGE (TOP VIEW)

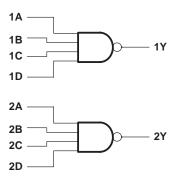


SN54ALS40A . . . FK PACKAGE (TOP VIEW)



NC-No internal connection

logic diagram (positive logic)



SDAS197 - D2661, APRIL 1984 - REVISED MAY 1986

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC}		 $\dots \dots \dots \ 7 \ V$
Input voltage		 $\dots \dots \dots \ 7 \ V$
Operating free-air temperature range:		
	SN74ALS40A	 \dots 0°C to 70°C
Storage temperature range		 -65°C to 150°C

recommended operating conditions

		SN54ALS40A		SN74ALS40A			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
IOH	High-level output current			-1			-2.6	mA
lOL	Low-level output current			12			24	mA
TA	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN	SN54ALS40A			SN74ALS40A		
			MIN	TYP [†]	MAX	MIN	TYP†	MAX	UNIT
VIK	V _{CC} = 4.5 V,	I _I = -18 mA			-1.5			-1.5	V
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2			V _{CC} -2			
V_{OH}	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -1 \text{ mA}$	2.3	3.3					V
	V _{CC} = 4.5 V,	$I_{OH} = -2.6 \text{ mA}$				2.4	3.2		
\/	$V_{CC} = 4.5 \text{ V},$	I _{OL} = 12 mA		0.25	0.4		0.25	0.4	V
V _{OL}	$V_{CC} = 4.5 \text{ V},$	I _{OL} = 24 mA					0.35	0.5	V
ΙĮ	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA
lН	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μΑ
Ι _Ι Γ	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.1			-0.1	mA
I _O ‡	$V_{CC} = 5.5 \text{ V},$	V _O = 2.25 V	-30	•	-112	-30		- 112	mA
^I CCH	V _{CC} = 5.5 V,	V _I = 0 V		0.43	0.8		0.43	0.8	mA
ICCL	V _{CC} = 5.5 V,	V _I = 4.5 V		2.4	3.9		2.4	3.9	mA

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25_C$.

switching characteristics (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V, C _L = 50 pF, R _L = 500 Ω, T _A = 25°C 'ALS40A TYP	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V,}$ $C_L = 50 \text{ pF,}$ $R_L = 500 \Omega,$ $T_A = \text{MIN to MAX}$ $SN54ALS40A SN74ALS40A$ $MIN MAX MIN MAX$ $2 10 2 8$			UNIT	
^t PLH	Λ	V	5	2	10	2	8	20
t _{PHL}	Any	Ţ	5	2	10	2	7	ns

NOTE 1: Load circuit and voltage waveforms are shown in Section 1.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS

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